

Notice of References Cited

Application/Control No.

10/537,395

Applicant(s)/Patent Under
Reexamination
DRONNE ET AL.

Examiner

ANDREW WENDELL

Art Unit

2618

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0009580	01-2003	Chen et al.	709/231
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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